								Sheet 1	of <u>1</u>
FORM PTO-1449				OF COMMERCE EMARK OFFICE			APPLICATION NO. 09/603,204		
PE C					FIRST NAME				-
OLIST OF REFERENCES CITED BY APPLICANT					Kyung-geun LEE et al.				
(Use several sheets if necessar				FILING DATE		GROUP ART UNIT			
					June 26, 2000			2655	
U.S. PATENT DOCUMENTS									
*EXAMINER		DOCUMENT	5		CLAC			JB- ASS	FILING DATE
INITIAL		NO.	DATE	NAME	<u></u>	CLASS		<u></u>	
	AA						111	CHIL	/ニリ
	AB		_				DE	C U I 2	.003
FOREIGN PATENT DOCUMENTS  Technology Center 2600									
		DOCUMENT					SUB-		LATION
		NO.	DATE	COUNT	RY	CLASS	CLASS	YES	NO
UR	AC	60-020326 V	02/01/85	Japan JP	၁			abstract	
lok	AD	60-066341 1	04/16/85	Japan J f	<b>≥</b> 0		-	abstract	
ac	AE	01-150230	06/13/89	Japan f	<b>°</b> 0		)	abstract	
UR	AF	64-046231	02/20/89	Aabau T t	20	•		abstract	
COR	AG	02-230515	09/12/90	Pabau 2 b	O			abstract	
ack	AH	06-295458	10/21/94	Japan Jf	<b>20</b>		)	abstract	
Col	Al	11-2731/15	10/08/99	Japan Jf	00		)	abstract	
Cell	AJ	03-022223 レ	01/30/91	Japan J p	٥١			abstract	
Cer	AK	2000-003526 2	01/07/00	Tabau— 2_t	0			abstract	
OR	AL	06-215438	08/05/94	Japan 5	29		-	abstract	
Col.	AM	62-008371	01/16/87	Japan-J	>0			abstract	
OTHER REF	EREN	CES (Includina Al	uthor. Title. I	Date, Pertinent Pa	ages, Etc.)				
	AN								
		<u> </u>	· · · · · · · · · · · · · · · · · · ·	- Iname	ONCIDE	<u> </u>			
EXAMINER	2D	0.21	DATE	CONSIDERED					
EXAMINER DATE CONSIDERED  12-9-03									

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.